### PATENT COOPERATION TREATY

## **PCT**

## INTERNATIONAL PRELIMINARY REPORT ON PATENTABILITY

(Chapter II of the Patent Cooperation Treaty)

(PCT Article 36 and Rule 70)

Applicant's or agent's file reference									
WK04-043-PCT	FOR FURTHER ACTION See Form PCT/IPEA/416								
International application No. PCT/JP2004/018432	International filing date 03.12.2004	(day/month/year)	Priority date (day/month/year) 24.12.2003						
International Patent Classification (IPC) or n H01L29/739, H01L29/78, H01L29/1	ational classification and O	IPC							
Applicant									
TOYOTA JIDOSHA KABUSHIKI KA	AISHA et al.								
This report is the international pre Authority under Article 35 and tree	eliminary examination r	eport, established by	this International Preliminary Examining						
Authority under Article 35 and transmitted to the applicant according to Article 36.  This REPORT consists of a total of 6 sheets, including this cover sheet.									
			ets as follows:						
<ul> <li>a.          Sent to the applicant and to the International Bureau) a total of 4 sheets, as follows:         Sheets of the description, claims and/or drawings which have been amended and are the basis of this report and/or sheets containing rectifications authorized by this Authority (see Rule 70.16 and Section 607 of the Administrative Instructions).</li> </ul>									
sheets which supersed beyond the disclosure Supplemental Box.	de earlier sheets, but v in the international ap	which this Authority co plication as filed, as in	nsiders contain an amendment that goes ndicated in item 4 of Box No. I and the						
b. (sent to the International B sequence listing and/or tab Box Relating to Sequence			nber of electronic carrier(s)) , containing a rm only, as indicated in the Supplemental re Instructions).						
4. This report contains indications re	lating to the following i	tems:							
☑ Box No. I Basis of the opir	nion								
☐ Box No. II Priority									
☐ Box No. III Non-establishme	ent of opinion with rega	ard to novelty, inventiv	ve step and industrial applicability						
BOX NO. IV Lack of unity of i	invention								
applicability; cita	Box No. V Reasoned statement under Article 35(2) with regard to novelty, inventive step or industrial applicability; citations and explanations supporting such statement								
☐ Box No. VI Certain docume									
Box No. VII Certain defects in the international application									
☐ Box No. VIII Certain observat	tions on the internatior	al application	•						
Date of submission of the demand		Date of completion of	this report						
06.10.2005		22.03.2006							
Name and mailing address of the international preliminary examining authority:	al	Authorized Officer							
European Patent Office - P.B. NL-2280 HV Rijswijk - Pays Ba Tel. +31 70 340 - 2040 Tx: 31 0	as	Baillet, B	September 1 de la company de l						
Fax: +31 70 340 - 3016		Telephone No. +31 70 340-3379							

## INTERNATIONAL PRELIMINARY REPORT ON PATENTABILITY

International application No. PCT/JP2004/018432

_	Box No. I Basis of the report
1.	With regard to the <b>language</b> , this report is based on the international application in the language in which it will filed, unless otherwise indicated under this item.
	<ul> <li>□ This report is based on translations from the original language into the following language, which is the language of a translation furnished for the purposes of:</li> <li>□ international search (under Rules 12.3 and 23.1(b))</li> <li>□ publication of the international application (under Rule 12.4)</li> <li>□ international preliminary examination (under Rules 55.2 and/or 55.3)</li> </ul>
2.	With regard to the <b>elements*</b> of the international application, this report is based on (replacement sheets which have been furnished to the receiving Office in response to an invitation under Article 14 are referred to in this report as "originally filed" and are not annexed to this report):
	Description, Pages
	1-33 as originally filed
	Claims, Numbers
	1-9 received on 06.10.2005 with letter of 03.10.2005
	Drawings, Sheets
	1/17-17/17 as originally filed
	☐ a sequence listing and/or any related table(s) - see Supplemental Box Relating to Sequence Listing
3.	<ul> <li>□ The amendments have resulted in the cancellation of:</li> <li>□ the description, pages</li> <li>□ the claims, Nos.</li> <li>□ the drawings, sheets/figs</li> <li>□ the sequence listing (specify):</li> <li>□ any table(s) related to sequence listing (specify):</li> </ul>
4.	<ul> <li>□ This report has been established as if (some of) the amendments annexed to this report and listed below had not been made, since they have been considered to go beyond the disclosure as filed, as indicated in the Supplemental Box (Rule 70.2(c)).</li> <li>□ the description, pages</li> <li>□ the claims, Nos.</li> <li>□ the drawings, sheets/figs</li> <li>□ the sequence listing (specify):</li> <li>□ any table(s) related to sequence listing (specify):</li> </ul>
	* If item 4 applies, some or all of these sheets may be marked "superseded."

## INTERNATIONAL PRELIMINARY REPORT ON PATENTABILITY

International application No. PCT/JP2004/018432

_	Bo	x No. IV	Lack of unity of i	nvontie				·		
_										
1.		☐ restr ☐ paid ☐ paid	nse to the invitation icted the claims. additional fees. additional fees unde er restricted nor pai	er prote	st.	additional fe	ees, the applic	cant has:		
2.	⊠	•								
3.	Thi	s Authorit	y considers that the	require	ment of un	ity of inven	ntion in accord	ance with Ru	les 13.1, 13.2 ar	nd 13.3
		complied	d with.							
	□ not complied with for the following reasons:									
		see sep	arate sheet							
4.	Cor	nsequentl	y, this report has be	en esta	blished in r	espect of t	he following p	arts of the int	ernational applic	cation:
	$\boxtimes$	all parts.							<b>ар</b> рпо	adon.
		the parts	relating to claims N	los						
Box No. V Reasoned statement under Article 35(2) with regard to novelty, inventive step or industry										
	app	licability	; citations and exp	lanatio	ns suppor	ting such	statement	voity, mvent		ıstriai
1.	Stat	tement								
	Nov	elty (N)		Yes: No:	Claims Claims	1-9				
	Inventive step (IS)		Yes: No:	Claims Claims	1-9			. •		
	Indu	ıstrial app	licability (IA)	Yes: No:	Claims Claims	1-9				
2.	Cita	tions and	explanations (Rule	70.7):						

see separate sheet

## AP3 Rec'd PCT/PTO 05 JUN 2006

## 10/581664

INTERNATIONAL PRELIMINARY REPORT ON PATENTABILITY (SEPARATE SHEET)

International application No.

PCT/JP2004/018432

#### Reference is made to the following documents:

D4: US-B1-6 518 629 (KUSHIDA TOMOYOSHI ET AL) 11 February 2003 (2003-02-11)

D6: PATENT ABSTRACTS OF JAPAN vol. 1997, no. 03, 31 March 1997 (1997-03-31) -& JP 08 316479 A (MITSUBISHI ELECTRIC CORP), 29 November 1996 (1996-11-29)

#### Re Item IV

#### Lack of unity of invention

- 1. This Authority considers that there are 3 inventions covered by the claims indicated as follows:
- I: Claims 1, 2 and 9, as depending on claim 1, directed to an IGBT comprising an intermediate region of a first semiconductivity type and a barrier region of a second conductivity type formed within the intermediate region.
- II: Claims 3 and 9, as depending on claim 3, directed to an IGBT comprising an intermediate region of a first semiconductivity type and a barrier region of the first semiconductivity type formed within the intermediate region.
- III: Claims 4-8 and 9, as depending on one of claims 4-8, directed to an IGBT comprising an intermediate region of the first conductivity type and a plurality of barrier regions formed within the intermediate region.
- 1.1 The reasons for which the inventions are not so linked as to form a single general inventive concept, as required by Rule 13.1 PCT, are as follows:
- 1.2 The common technical features between inventions I, II and III as disclosed above, are an IGBT comprising an intermediate region of a first conductivity type and a barrier region formed within the intermediate region. However, document D4 discloses (see D4, column 4, line 66 to column 5, line 13 and figure 7) an IGBT having a barrier layer formed in the intermediate region. Hence the common technical features between inventions I, II and III is not new and cannot be considered as a common inventive concept.

#### Re Item V

(I)

Reasoned statement with regard to novelty, inventive step or industrial applicability; citations and explanations supporting such statement

- 2. The document D6 is regarded as the closest prior art to the subject-matter of claim 1 and discloses (the references in parentheses applying to this document) an IGBT comprising an emitter electrode (45), a top region of the second conductivity type (45) connected to the emitter electrode, a deep region of the second conductivity type (42), an intermediate region of a first conductivity type (44) insulating the top region and the deep region, a collector region of the first conductivity type (41) connected to the deep region and being isolated from the intermediate region by the deep region, a collector electrode (52) connected to the collector region, a gate electrode (49) facing a portion of the intermediate region via an insulating layer (56), the intermediate region comprising a dense portion (91) directly connected to the emitter electrode.
- 2.1 The subject-matter of claim 1 differs form the content of D6 in that the IGBT of claim 1 comprises a barrier region comprising a semiconductor region of the second conductivity type formed within the intermediate region, this barrier region being in contact with the dense region and separated from the deep region by the main portion. The subject-matter of claim 1 is therefore new (Article 33(2) PCT).
- 2.2 The existence of the barrier region in contact with the dense portion, causes the accumulation of the minority carriers in the intermediate region, which reduces the onvoltage of the IGBT. This is neither disclosed nor suggested in the prior art, hence claim 1 is considered as involving an inventive step (Article 33(3) PCT).
- 2.3 Claims 2 and 9, when depending on claims 1 or 2, are dependant on claim 1 and as such also meets the requirements of the PCT with respect to novelty and inventive step.
- 3. Document D4 is regarded as being the closest prior art to the subject-matter of claims 3 and 4 and shows (the references in parentheses applying to this document, see in particular its figures 7 and 8) an IGBT comprising an emitter electrode (28), a top region of a second conductivity type (24) connected to the emitter electrode, a deep region of the second conductivity type (12), an intermediate region of a first conductivity type (18) connected to the emitter electrode and isolating the top region and the deep region, a collector region of the first conductivity type (10) connected to the deep region

## INTERNATIONAL PRELIMINARY REPORT ON PATENTABILITY (SEPARATE SHEET)

C

PCT/JP2004/018432

and isolated from the intermediate region by the deep region, a collector electrode (30) connected to the collector region, a gate electrode (22) facing a portion of the intermediate region via an insulating layer (20), and a plurality of barrier regions (14) formed within the intermediate region.

- 3.1 The subject-matter of claim 3 differs from the content of D4, in that in claim 3 the barrier region has the first conductivity type an has a higher concentration in impurities than the intermediate region. The subject-matter of claim 3 is therefore new (Article 33(2) PCT).
- 3.2 The first conductivity type doping of the barrier region allows the discharge of the minority carriers via the barrier region, hence repressing the latch up effect, which could be caused by the flow of the minority carriers through the emitter. This is neither disclosed nor suggested by the prior art, hence claim 3 is considered as involving an inventive step (Article 33(3) PCT).
- 3.3 Claim 9, when depending on claim 3, also meets as such the requirements of the PCT with respect to novelty and inventive step.
- 3.4 The subject-matter of claim 4 differs from the content of D4, in that in claim 4 the plurality of barrier region within the intermediate region are distributed along a direction extending between the top region and the deep region. The subject-matter of claim 4 is therefore new (Article 33(2) PCT).
- 3.5 This characteristic allows the accumulation of minority carriers throughout the intermediate region, then reducing the on-voltage and is neither disclosed nor suggested by the prior art, hence claim 4 is considered as involving an inventive step (Article 33(3) PCT).
- 3.6 Claims 5-8 and claim 9, when depending on claim 4, depend on claim 4 and as such also meet the requirements of the PCT with respect to novelty and inventive step.

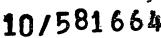


10

15

20







# 10/581664 P3 Rec'd PCT/PTO 05 JUN 20

Amendments under Article 34(2)b of PCT

#### **CLAIMS**

5 A semiconductor device of IGBT comprising: 1.

an emitter electrode:

a top region of a second conductivity type connected to the emitter electrode;

a deep region of the second conductivity type;

an intermediate region of a first conductivity type isolating the top region and the deep region;

a collector region of the first conductivity type connected to the deep region, the collector region being isolated from the intermediate region by the deep region;

a collector electrode connected to the collector region;

a gate electrode facing a portion of the intermediate region via an insulating layer, the portion of the intermediate region isolating the top region and the deep region; and

a barrier region comprising a semiconductor region of the second conductivity type formed within the intermediate region,

wherein the intermediate region comprises a dense portion directly connected to the emitter electrode, and a main portion connected to the emitter electrode via the dense portion,

wherein the barrier region is in contact with the dense portion, and is separated from the deep region by the main portion. 25

- 2. A semiconductor device according to claim 1, wherein the barrier region further comprises an insulator.
- 30 3. A semiconductor device of IGBT comprising:







5

10

20





an emitter electrode;

a top region of a second conductivity type connected to the emitter electrode;

a deep region of the second conductivity type;

an intermediate region of a first conductivity type connected to the emitter electrode, the intermediate region isolating the top region and the deep region;

a collector region of the first conductivity type connected to the deep region, the collector region being isolated from the intermediate region by the deep region;

- a collector electrode connected to the collector region;
- a gate electrode facing a portion of the intermediate region via an insulating layer, the portion of the intermediate region isolating the top region and the deep region; and
- a barrier region comprising a semiconductor region of the first conductivity type formed within the intermediate region;

wherein the barrier region has a higher concentration of impurities than the intermediate region, and the barrier region is formed along a boundary between the top region and the intermediate region, and is electrically connected to the emitter electrode.

- 4. A semiconductor device of IGBT comprising:
  - an emitter electrode;
- a top region of a second conductivity type connected to the emitter 25 electrode;
  - a deep region of the second conductivity type;
  - an intermediate region of a first conductivity type connected to the emitter electrode, the intermediate region isolating the top region and the deep region;







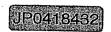
5

10

15

20

25



a collector region of the first conductivity type connected to the deep region, the collector region being isolated from the intermediate region by the deep region;

a collector electrode connected to the collector region;

a gate electrode facing a portion of the intermediate region via an insulating layer, the portion of the intermediate region isolating the top region and the deep region; and

a plurality of barrier regions formed within the intermediate region; wherein the barrier regions are distributed within the intermediate region along a direction extending between the top region and the deep region.

5. A semiconductor device according to claims 4,

wherein the intermediate region comprises a dense portion directly connected to the emitter electrode, and a main portion connected to the emitter electrode via the dense portion,

wherein at least one of the barrier regions is formed in the vicinity of a boundary between the dense portion and the main portion,

wherein at least the other of the barrier regions is the second conductivity type, is formed in the vicinity of a boundary between the main portion and the deep region, and is electrically disconnected from the emitter electrode and the deep region.

6. A semiconductor device according to claims 4,

wherein the intermediate region comprises a dense portion directly connected to the emitter electrode, and a main portion connected to the emitter electrode via the dense portion,

wherein at least one of the barrier regions is formed in the vicinity of a boundary between the dense portion and the main portion,





36/1

wherein at least the other of the barrier regions is the second conductivity type, is formed at a boundary between the main portion and the deep region, and has a higher concentration of impurities than the deep region.

- 5 7. A semiconductor device according to claims 5 or 6, wherein at least a portion of the barrier regions are located on a path along which carriers flow.
  - 8. A semiconductor device according to claims 7,
- wherein a plurality of pairs of barrier layer and intermediate layer is stacked.
  - 9. A semiconductor device according to any one of the preceding claims,
     wherein the thickness of the top region is less than the thickness of the
     15 barrier region.

